

Sheet 1 of 2

Form PTO-1449 (REV. 1/06) US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY DOCKET NO. 128939	APPLICATION NO. 10/588,163
	APPLICANT(S) Atsushi YAMAGUCHI	
	FILING DATE August 1, 2006	GROUP 2627

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	2	6,341,007	01/22/2002	NISHI et al.
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